ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention

STRUCTURE FOR MEASUREMENT OF CAPACITANCE OF ULTRA-THIN DIELECTRICS

Application Number:

Confirmation Number:

First Named Applicant:

Edward Maciejewski

Attorney Docket Number:

BUR920030052US1

Art Unit:

Examiner:

Search string:

(4795964 or 6133746 or 6456105 or 6472233 or 6476632).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
mx	1	4795964	1989-01-03	Mahant-Shetti et al.			
MK	2	6133746	2000-10-17	Fang et al.			
П	3	6456105	2002-09-24	Tao			
\prod_{i}	4	6472233	2002-10-29	Ahmed et al.			
$\overline{\mathbb{V}}$	5	6476632	2002-11-05	La Rosa et al.			

Signature

Examiner Name	Date
Maria Mramshaya	12/20/09

IPE'					Docket Number (Optional) BUR9200300521		Application Number Not Yet Assigned			
O INFORMATION DISCLOSURE CITATION					Applicant(s) Nowak et al.	031 1	Not Tet Assigned			
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EM & HIVE	38 T. Sept.			U.S. PATI	ENT DOCUMENTS	-				
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		-		OTHER D	OCUMENTS (Including A	luthor, Title, D	ate, Pertinent Pa	ges, Etc.)	<u> </u>	
1/		"A Simple Method for Chen, Dennis Sylvesto	r On-Chip, Sub-Fen er. Cheuming Hu, II	nto Farad I EEE, Vol. 1	Interconnect Capacitance 18, No. 1, January 1997, 1	Measuremen nage	t", Bruce W. M	IcGaughy,	James C.	
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Marine Kromshowa					DATE CONSIDERED					
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